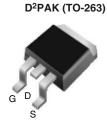


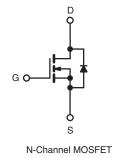
2SK4184-VB Datasheet N-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^{a, e}	Q _g (Max)			
60	0.032 at V _{GS} = 10 V	50	66 nC			
	0.035 at V _{GS} = 4.5 V	40	00110			

FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- Surface Mount
- Available in Tape and Reel
- Dynamic dV/dt Rating
- Logic-Level Gate Drive
- Fast Switching
- Compliant to RoHS Directive 2002/95/EC





ABSOLUTE MAXIMUM RATINGS ($T_C = 25 \text{ °C}$, unless otherwise noted)									
PARAMETER	SYMBOL	LIMIT	UNIT						
Drain-Source Voltage			V _{DS}	60	V				
Gate-Source Voltage	V _{GS}	± 10	v						
Continuous Drain Current ^f	V _{GS} at 10 V	T _C = 25 °C T _C = 100 °C	- I _D	50					
Continuous Drain Current	VGS at 10 V			36	А				
Pulsed Drain Current ^a			I _{DM}	200					
Linear Derating Factor				1.0	W/°C				
Linear Derating Factor (PCB Mount) ^e		0.025	VV/ C						
Single Pulse Avalanche Energy ^b	E _{AS}	400	mJ						
Maximum Power Dissipation	T _C = 25 °C T _A = 25 °C		PD	150	W				
Maximum Power Dissipation (PCB Mount) ^e			гD	3.7	vv				
Peak Diode Recovery dV/dt ^c	dV/dt	4.5	V/ns						
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	°C				
Soldering Recommendations (Peak Temperature) ^d	for	10 s		300 ^d	U				

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, $L = 179 \mu\text{H}$, $R_g = 25 \Omega$, $I_{AS} = 51 \text{ A}$ (see fig. 12). c. $I_{SD} \le 51 \text{ A}$, dl/dt $\le 250 \text{ A/}\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_J \le 175 \text{ °C}$.

f. Current limited by the package, (die current = 51 A).



d. 1.6 mm from case.

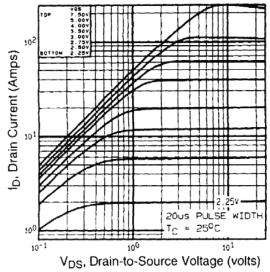
e. When mounted on 1" square PCB (FR-4 or G-10 material).



THERMAL RESISTANCE RATI	NGS	T				1		
PARAMETER	SYMBOL	TYP.		MAX.		UNIT		
Maximum Junction-to-Ambient	R _{thJA}	- 62			°C/W			
Maximum Junction-to-Ambient (PCB Mount) ^a	R _{thJA}	- 40						
Maximum Junction-to-Case (Drain)	R _{thJC}	- 1.0						
ote When mounted on 1" square PCB (FR-4	or G-10 material).						
SPECIFICATIONS (T _J = 25 $^{\circ}$ C, U	nless otherw	vise noted)						
PARAMETER	SYMBOL	TEST CONDITIONS		ONS	MIN.	TYP.	MAX.	UNIT
Static		•						•
Drain-Source Breakdown Voltage	V _{DS}	V _{GS}	= 0, I _D = 25	i0 μA	60	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, $I_D = 1$ mA		-	0.070	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$		1.0	-	3.0	V	
Gate-Source Leakage	I _{GSS}	$V_{GS} = \pm 10 V$		-	-	± 100	nA	
-		$V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		-	-	25	μA	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 48 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 150 \text{ °C}$		-	-	250		
		V _{GS} = 10 V	I _D		-	0.032	-	Ω
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 4.5 V	_		_	0.035	_	
Forward Transconductance	9 _{fs}	$V_{\text{GS}} = 4.5 \text{ V}$ $I_{\text{D}} = 13 \text{ A}^{\circ}$ $V_{\text{DS}} = 25 \text{ V}, I_{\text{D}} = 21 \text{ A}^{\circ}$		23	-	-	s	
Dynamic	313							<u> </u>
Input Capacitance	C _{iss}				-	3000	_	
Output Capacitance	C _{oss}	-	$V_{GS} = 0 V,$ $V_{DS} = 25 V$		_	1000	-	pF
Reverse Transfer Capacitance	C _{oss}		0 MHz, see			200	-	
Total Gate Charge	Q _g						-	
Gate-Source Charge	-	$I_{\rm D} = 51 \text{ A}, V_{\rm DS} = 48 \text{ V},$		A, V _{DS} = 48 V,	_	60 10	-	nC
6	Q _{gs}	V _{GS} = 5.0 V	see fiç	g. 6 and 13 ^b	_	40		no
Gate-Drain Charge	Q _{gd}				-		-	
Turn-On Delay Time	t _{d(on)}	-			-	17	-	ns
Rise Time	t _r		= 30 V, I _D = B _D = 0.56 C	51 A, 2, see fig. 10 ^b	-	230	-	
Turn-Off Delay Time	t _{d(off)}		н <u>р</u> = 0.00 ы	, see ng. 10	-	42	-	
Fall Time	t _f				-	110	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH	
Internal Source Inductance	L _S			-	7.5	-		
Drain-Source Body Diode Characteristic	s							•
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	50 ^c	A	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	200		
Body Diode Voltage	V _{SD}	$T_J = 25 \text{ °C}, I_S = 51 \text{ A}, V_{GS} = 0 \text{ V}^{b}$		-	-	2.5	V	
Body Diode Reverse Recovery Time	t _{rr}	$T_{\rm J} = 25 \text{ °C, } I_{\rm F} = 51 \text{ A, } dl/dt = 100 \text{ A}/\mu\text{s}^{\rm b}$		-	130	180	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.84	1.3	μC	
Forward Turn-On Time	t _{on}	Intuinaia tu		is negligible (turn	 			

Notes
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 μs; duty cycle ≤ 2 %.
c. Current limited by the package, (Die Current = 51 A).



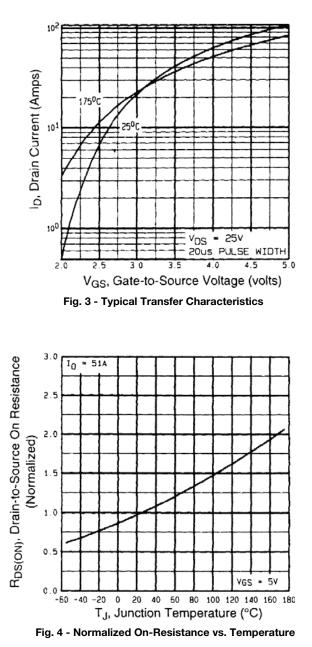


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C





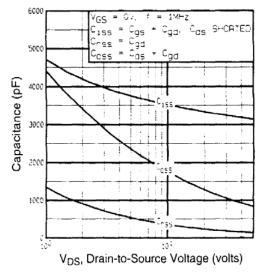


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

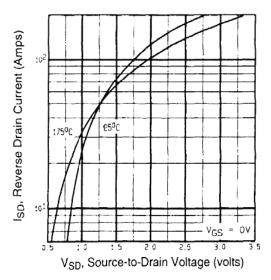


Fig. 7 - Typical Source-Drain Diode Forward Voltage

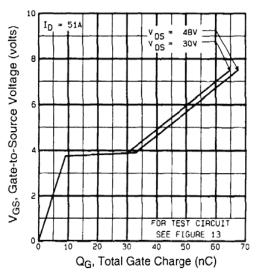
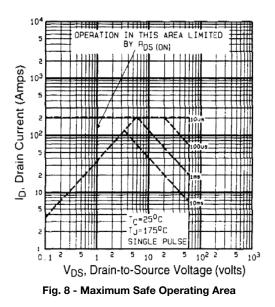


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





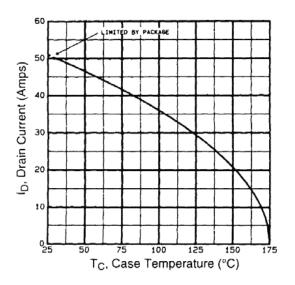


Fig. 9 - Maximum Drain Current vs. Case Temperature

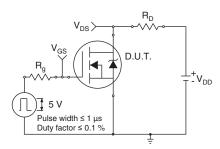


Fig. 10a - Switching Time Test Circuit

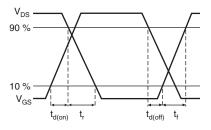


Fig. 10b - Switching Time Waveforms

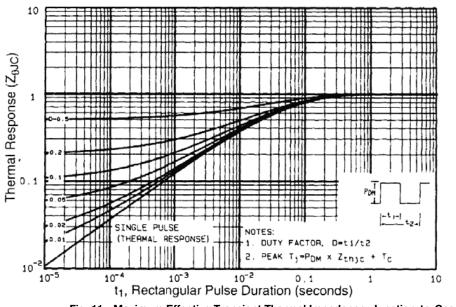


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



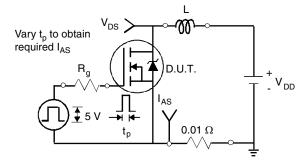


Fig. 12a - Unclamped Inductive Test Circuit

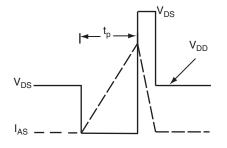


Fig. 12b - Unclamped Inductive Waveforms



Fig. 12c - Maximum Avalanche Energy vs. Drain Current

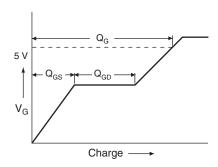


Fig. 13a - Basic Gate Charge Waveform

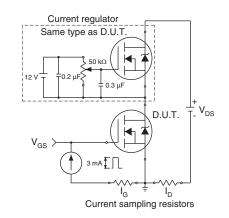
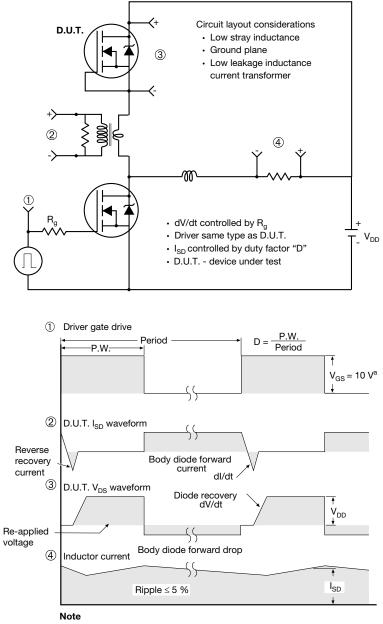


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

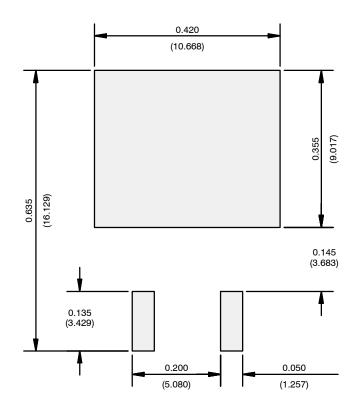


a. V_{GS} = 5 V for logic level devices

Fig. 14 - For N-Channel



RECOMMENDED MINIMUM PADS FOR D²PAK: 3-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)



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